

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10589915	CHONG ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
ROBERT HUBER	2892	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	314, 613 (keyword)	5/14/08	RH
711	104 (keyword)	5/14/08	RH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search - EAST (USPAT, USPGPUB, USOCR) - see printout	5/13/08	RH
PLUS search - keywords: chalcogenide, phase, change, pcram, multiple, plurality, many, layer, film, memory, temperature, electrode, contact	5/14/08	RH
EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	5/13/08 - 5/15/08, 5/21/08	RH
Suggested EAST Search from Thao Le: @ad<= 20040219 and GeTe same Sb.sub.2Te.sub.3	5/21/08	RH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>